

# FISCHERSCOPE® MMS® PC2

The Universal Multi-Measuring System  
for Coating Thickness Measurement and Material Testing



**fischer**®

# FISCHERSCOPE® MMS® PC2 – The Versatile Benchtop Instrument

The FISCHERSCOPE MMS® PC2® is used wherever quality is a top priority: in incoming inspection, in final inspection, during ongoing production, for sampling or routine tests. And that in all industries. As a result of its modern design, the MMS PC2 can be adapted specifically to your needs and expanded at any time. Whether coating thickness, electrical conductivity or ferrite content, with the MMS PC2 you will always measure precisely and correctly.

MMS PC2 – one measuring instrument for all measuring applications.



## Coating thickness measurement

Measurement of the coating thickness with the following material combinations:

- Almost all coating materials on metals
- Duplex coating systems
- Metallic coatings on electrically nonconductive materials
- Organic coatings, e.g. oil or grease films

## Material testing

- Measurement of the electrical conductivity of non-ferrous metals
- Testing of the quality of weld seams, ferrite content in austenitic or duplex steels

## At home in all industries

- Automotive
- Electronics industry
- Paint industry
- Coating technologies
- Gold, watches, jewellery
- Material analysis and material testing

## Versatile in application

- Quality assurance in incoming and outgoing inspections
- Routine tests or sampling in ongoing production
- Continuous production control
- Can be integrated in quality management systems and company networks

## Measurement by hand or automated

- Automatically after touchdown of the probe
- At the push of a button or via external start
- In predefined time intervals
- Semiautomatically with motorised support stand or programmable XY measuring stage
- Automated via PLC unit
- Automated in production plants

## Modular design

- Eight modules with different test methods for coating thickness, conductivity and ferrite content are available

### Measurement of thin organic coatings, e.g. oils, with the hand probe Z15NG-TC

Hand probe with beta emitter for measurements according to the radiometric beta-backscatter method, an integrated temperature sensor serves to automatically compensate for the beta radiation damping through the air at different temperatures.



### Precise measurements on small parts with the motorised support stand V12 MOT

The FISCHERSCOPE MMS® PC2® automatically controls the upwards and downwards motion of the support stand and the measurement.



### Measurement of the chrome coating on pistons with the measurement probe V2EGA06H in the motorised support stand



### Incoming inspection

Measuring station with several module boards and probes for incoming inspection, mounted on a transport trolley for measuring different parts.





## Typical Configurations

### Anodising measuring station

Measuring station with several probes for testing various parts with different geometries without having to reinsert the probes. The correct probe is automatically activated when the application is selected. Measurement of the coating thickness and conductivity of anodised aluminum parts, search for causes in the case of colour differences.

#### Assembly

- Module SIGMASCOPE® with the probes ES40 and ES24 for conductivity measurement
- Module PERMASCOPE® with the inner measurement probe FAI3.3-150 and the curvature-compensated probe FTD3.3 for measuring the anodised coating thickness
- Support stand V12 MOT for semi-automatic measurement of many parts



### Electroplating measuring station

Measuring station for determining the coating thickness in the case of different part shapes, material combinations and surface finishes that are typical of electroplating companies. Even measurements on threads and rough surfaces are possible with a very high repeatability.

#### Assembly

- Module PERMASCOPE® with the probes FGA06HMC for measurement on small parts and F20H for measurement on rough surfaces, probe V7FKB4 for measurement of phosphate-coatings
- Module SIGMASCOPE®/PHASCOPE® 1 with the probes ESD20 Zn and ESD2.4 for measurement of copper or zinc coatings on steel and cast-iron parts
- Support stand V12 MOT or V12 BASE for measurement on small parts such as nuts and screws

### Measuring station lacquer laboratory

Measuring station for determining the coating thickness of:

- Lacquer coatings on nonferrous metals
- Lacquer coatings on iron or steel
- Duplex measurements, i.e. lacquer on zinc on iron or steel with simultaneous measurement of both coatings

#### Assembly

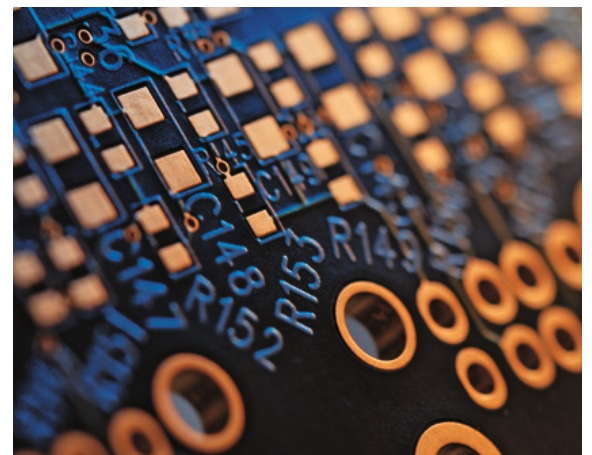
- Module PERMASCOPE® with probe FD13H
- Module PHASCOPE® DUPLEX with probe ESG20
- Support stand V12 MOT for automatic scanning of lacquered metal sheets

### Measuring station printed circuit board (PCB)

Measuring station for almost all measuring applications with PCB's. In the case of extremely thin coatings, we also recommend the instruments of our X-RAY product line.

#### Assembly

- Module SIGMASCOPE®/PHASCOPE® 2 with probe ESL080V for measuring the Cu through-connection
- Module SIGMASCOPE®/PHASCOPE® 1 with probe ESD20 Cu for measuring the copper coatings under solder resist coatings
- Module SR-SCOPE® with probe ERCU-D10 for measuring the copper coating on multilayers without interference in the measuring result from copper coatings on inner layers
- Module PERMASCOPE® with probe FTA3.3-5.6HF for measuring the solder resist coatings and protective coatings on thin copper intermediate layers and probe FKB10-OD for measuring the total PCB thickness



The FISCHERSCOPE MMS® PC2® offers a wide variety of possibilities for evaluating your measuring results.

## Evaluation and statistics functions

- Display of important statistical characteristics such as mean value, standard deviation, min, max, and range
- Statistics display of the important characteristics in the block and final result
- Graphic display as a histogram, sum frequency chart, FDD
- Possibility of entering the process tolerance limits and calculation of the corresponding process capability indices  $c_p$  and  $c_{pk}$

## Measurement print forms

For a clear presentation of your measurement results, you can create print forms that present the measurements and statistical evaluations in a clearly organised manner. It is possible to incorporate e.g. your company logo and a sketch of the specimen in the print forms. You may define the layout and contents of a print form in templates. You can create a separate template for each application.

## Data export

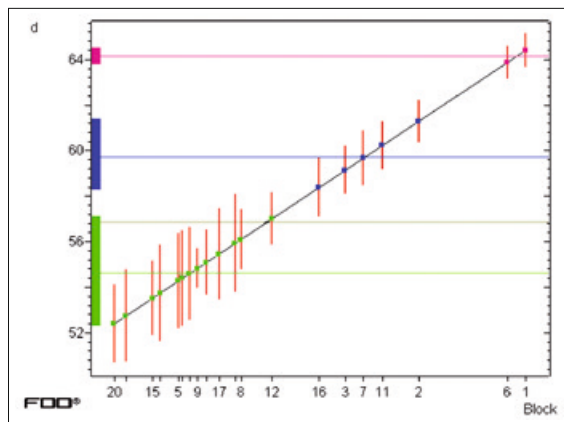
You can export your measuring data quickly and easily. It is possible to define what to export in templates. You can create a different template for each application.

### Possible formats

PDF, ASCII, Excel, Q-DAS, HTML

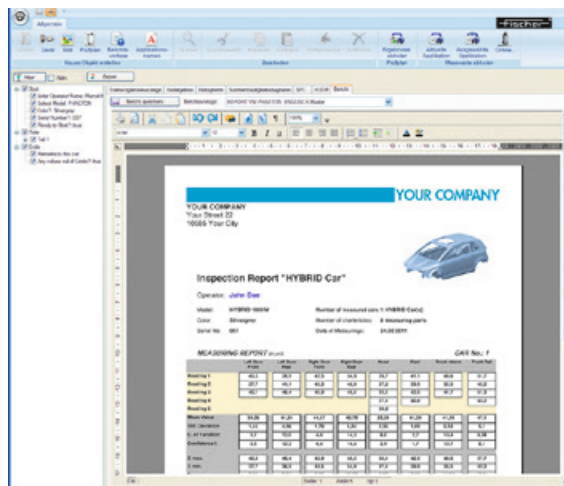
## Simple visualisation of the process quality with the factory diagnosis diagram (FDD®)

The FISCHERSCOPE MMS® PC2® offers the patented factory diagnosis diagram (FDD) from FISCHER, a graphic evaluation possibility that visualises the process at a glance. An easy-to-interpret chart provides a graphic overview of the distribution of manufacturing parameters such as e.g. the coating thickness. As a result of the colour display, you receive information for optimising the production process quickly and easily without statistical calculations of your own.

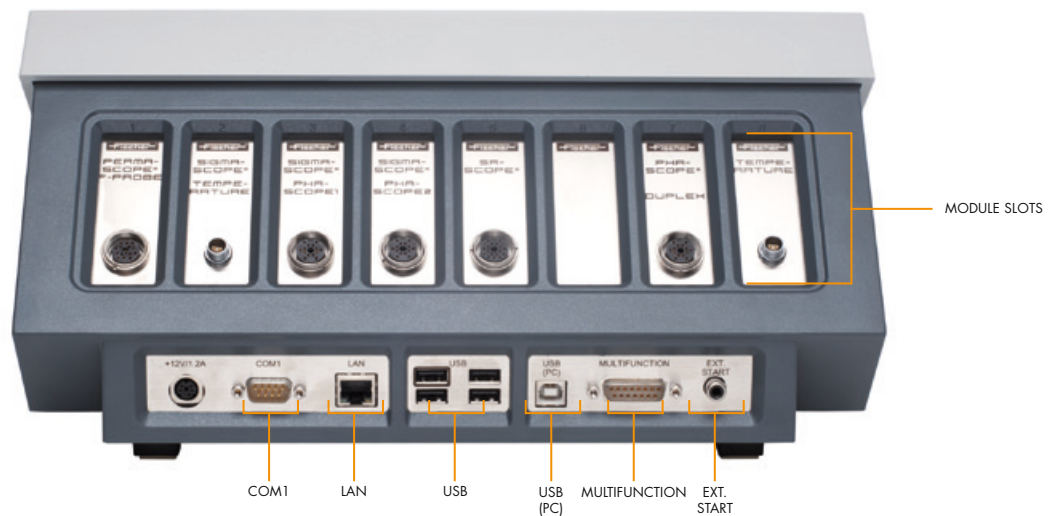


## FISCHER DataCenter

The PC software FISCHER DataCenter is included in the scope of supply of the FISCHERSCOPE® MMS® PC2. The DataCenter software makes it possible to easily and conveniently generate individual reports and design them with your own logos, images and graphics. You can integrate any desired measurements, statistical values and graphic displays via drag and drop. In addition, you can create report templates on the basis of scanned forms.



## Adaptable Due to Modular Structure



### 100 different applications – eight slots and more than 60 probes

Due to its modular design, the MMS PC2 is always right for your applications. Based on your measuring application, we assemble the measuring instrument for you with the right module boards and probes.

### Eight different module boards

The measurement of the physical quantities of coating thickness, electrical conductivity and ferrite content requires different test methods. In the case of coating thickness measurement, different test methods are used, depending on the coating/substrate material combination. In order to cover this wide range, we have developed eight different module boards for the MMS PC2.

### Changed requirements

You can upgrade the MMS PC2 at any time with further module boards and probes.

### Interfaces

- LAN network connection
- 5 USB connections for PC, printer etc.
- RS232 interface for connecting support stand, XY measuring stage, digital measuring aids or radio interface
- Multi-function connector, e.g. for connecting signal lights for reporting when tolerance limits are exceeded
- Optional: connection for PLC integration

### Features

- Coating thickness measurement and material testing with only one instrument
- Sturdy and very versatile bench-top instrument as a multifunctional measurement system with data archiving and measurement processing
- User-friendly work with a large, high-resolution LCD touchscreen and Windows® CE
- User interface can be switched between many European and Asian languages

### Evaluation and data export

- Statistics functions for evaluation of the measurements: sum frequency chart, histogram and factory diagnosis diagram (FDD)
- Various graphic measurement displays for a quick overview of the production process and the product quality
- Customer-specific recording of the measurement data
- Export of the result print forms and the measurements in different data formats for evaluation in external statistics programs
- Delivery with PC software FISCHER DataCenter with following functions: transfer and archiving of measurements, comprehensive statistical and graphic evaluation possibilities, easy creation and printing of individual test reports

## Hardware concept

Housing with 8 slots for module boards with different test methods.

## Test method

- Magnetic method (DIN EN ISO 2178)
- Magnetic induction method (DIN EN ISO 2178, ASTM D7091, ASTM B499, ASTM B244)
- Amplitude sensitive eddy current test method (DIN EN ISO 2360, ASTM D7091, ASTM B499, ASTM B244)
- Phase sensitive eddy current test method (DIN EN ISO 21968)
- Micro-resistance method (DIN EN 14571)
- Beta-backscatter method (DIN EN ISO 3543, ASTM B567a)

## Measured quantities

Coating thickness, electrical conductivity, ferrite content, temperature

## Measurement probes

Connection sockets on the module boards for all FISCHER probes, simultaneous connection of max. 8 measurement probes

## Software

- Windows® CE based program software
- Software available in European and Asian languages: German, English, French, Italian, Spanish, Czech, Polish, Turkish, Chinese and Japanese
- Inputs via touchscreen, mouse or keyboard (USB)
- Storage of applications, blocking of access to program functions to prevent operating errors, limit value monitoring, outlier control, calibration, block formation

## Measurement storage

The instrument stores measurements in application files. The following is also saved in these files: All settings, information on the measurement blocks, date, time and calibration data.

- Default mode: measurements are saved in successive blocks in the application. Automatic block formation after a specified number *n* of individual measurements. Automatic calculation of the mean value
- Matrix mode: measurements are stored in blocks which are set up in matrix form in the application. Block change in any desired block manually or automatically in a specified order

## Multi-channel measurement

Measurements from up to 8 measurement probes are displayed and stored parallel in one application.

## Measurement presentation

- Numeric display: list of the measurements with a large numeric display of the last individual measurement
- Specification limit display: graphical presentation of the measurements within specified limit values
- SPC chart: control chart presentation as  $x/R$  or  $x/s$  chart
- Simple display: numeric display of the last measurement
- Selectable unit of measurement for measured quantity
  - Coating thickness: metric or imperial
  - Ferrite: Fe% or WRC-FN
  - El. conductivity: % IACS or MS/m
  - Temperature: °C or °F
  - Free definition of a further unit of measurement, e.g. g/m<sup>2</sup>
- Selectable resolution of the measurement display

## Screen

Large, high-resolution colour display with touchscreen function. 170 mm x 130 mm (W x H) with 800 x 600 px

## Measurement accept

- Automatic after probe touchdown
- Through external start
- In continuous running mode at the push of a button
- Clocked in selected time intervals either after probe touchdown or after external start

## Evaluation

Statistical evaluation of test series with mean value, standard deviation, coefficient of variation, maximum and minimum value, number of measurements, individual and block statistics, calculation of the process capability factors.

$C_p$  and  $C_{pk}$ ; histogram, sum frequency chart with parameters of the distribution shape, FDD, evaluation from groups of blocks, filtered according to block designations.

## Dimensions (W x H x D)

360 mm x 170 mm x 270 mm

## Weight (fully equipped)

approx. 5 kg

## Ambient temperature

+10°C ... +40°C

## Connections (standard)

- 1 x COM1 – RS232 interface
- 1 x LAN network connection
- 4 x USB connections for keyboard, mouse, printer
- 1 x USB connection for PC
- Multi-function connector with signal outputs for upper and lower limit violations, external start
- Jack socket for connecting e.g. a button for externally triggering the measurement capture
- Voltage supply via AC adapter 12V/1.2 A

## Connectable printers

Printer with USB connection (2.0 compatible) which features one of the following printer language emulations: PCL, ESC/P

## Documentation

- Printout of individual measurements, block and final results, specification limits using print form templates. Printout of SPC charts, histogram, sum frequency chart and FDD
- Print form design with customer-specific information. The instrument can store any desired number of print forms

## Data storage

- In the internal memory of the instrument with 256 MB storage space
- On an external USB stick
- In the network

## Data export

- Online or offline output of the measurements via the USB interface to a PC
- Online or offline output of the measurements via the RS232 interface to a PC
- Export of result print forms as text files, ASCII files for importing to Excel spreadsheets, in Q-DAS or HTML format

## Module Boards/Areas of Application

Depending on the application, you can assemble your FISCHERSCOPE® MMS® PC2 with the following modules.

Applications	Module boards							Measuring method
	PERMASCOPE®	SIGMASCOPE® / PHASCOPE® 1	SIGMASCOPE® / PHASCOPE® 2	PHASCOPE® DUPLEX	NICKELSCOPE®	SR-SCOPE®	TEMPERATURE	
<b>Coating thickness measurement – electromagnetic measuring methods</b>								
Electrically nonconductive coatings on nonferrous metals	✓			✓				Eddy current measuring method DIN EN ISO 2360
Electrically nonconductive coatings on ferromagnetic substrate materials (steel or iron)	✓							Magnetic induction measuring method DIN EN ISO 2178
Duplex coatings in heavy corrosion protection (zinc thicknesses ≥ 70 µm)	✓							Magnetic induction measuring method DIN EN ISO 2178 Eddy current measuring method DIN EN ISO 2360
Corrosion protection coatings (zinc thicknesses approx. 5 – 20 µm)				✓				Magnetic induction measuring method DIN EN ISO 2178 Phase sensitive eddy current method DIN EN ISO 21968
Coatings of Cu, Zn, Ni on ferromagnetic substrate materials (steel or iron)		✓						Phase sensitive eddy current method DIN EN ISO 21968
Metal coatings with high electrical conductivity on substrate materials of low conductivity (e.g. Cu/Ms)		✓						
Individual thicknesses of a lacquer/zinc coating system (duplex coating) on thin metal sheets in a measurement process (zinc thicknesses 5 – 20 µm)				✓				
Copper on PCB material (Cu/Iso)		✓						
Copper coatings in PCB holes			✓					Phase sensitive eddy current method DIN EN ISO 21968
Galvanic nickel coatings on nonferrous metals or electrically nonconductive substrate material					✓			Magnetic method (DIN EN ISO 2178)
Non-magnetic thick coatings in the mm range (Cu, Al, Pb) on ferromagnetic substrate materials (steel or iron)					✓			
Copper coating thickness on laminates or multilayers, not affected by underlying copper coatings						✓	✓	Electrical resistance method DIN EN 14571

- Substrate material nonferrous metals
- Substrate material PCB material
- Ferromagnetic substrate materials
- Nonferrous metals and electrically nonconductive substrate materials





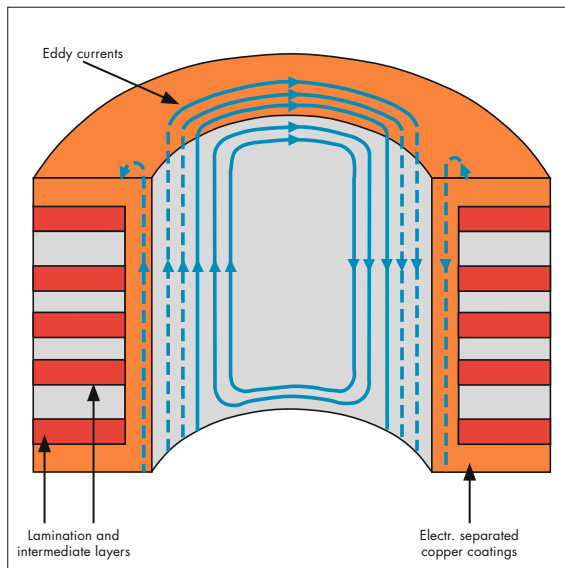
Applications	Module boards							Measuring method
	PERMASCOPE®	SIGMASCOPE® / PHASCOPE® 1	SIGMASCOPE® / PHASCOPE® 2	PHASCOPE® / DUPLEX	NICKELSCOPE®	SR-SCOPE	TEMPERATURE	
<b>Conductivity measurement</b>								
Electrical conductivity of nonferrous metals		✓						Phase sensitive Eddy current method DIN EN ISO 21968
<b>Ferrite content measurement</b>								
Ferrite content in austenitic and duplex steels	✓							Magnetic induction method DIN EN ISO 2178
<b>Temperature measurement</b>								
Temperature measurement with the temperature probe TF100A (temperature probe with Pt100 sensor)							✓	Temperature recording with a Pt100 sensor, measurement range -20°C to +80 °C
<b>Coating thickness measurement – beta-backscatter method</b>								
Plastic or metal coatings							✓	Beta-backscatter method DIN EN ISO 3543, ASTM B567, BS 5411
Oil or wax coatings on metals							✓	
Thickness inspection of foils, determination of the uniformity of cloths and fabrics								Beta-backscatter method

**Measurement ranges of the beta emitters**

Emitter		Pm-147	Tl-204	Sr-90	C-14
Coating	Substrate material	Measurement ranges in µm			
Ag, Rh, Pd	Cu, Ni, Fe	1.2 – 4.0	5.5 – 22	15 – 70	–
Al	Cu, Ni, Fe	4.5 – 20	25 – 100	90 – 400	–
Au	Cu, Ni, Fe	0.5 – 2.0	2.5 – 10	5.5 – 35	–
Cd	Cu, Ni, Fe	1.5 – 5.0	7.0 – 30	15 – 70	–
Cr	Al	2.0 – 8.0	8.0 – 30	–	–
SnPb(60/40)	Cu, Ni, Fe	1.1 – 4.5	5.0 – 28	10 – 80	–
Ni, Cu	Ag, Mo	1.5 – 5.0	9.0 – 30	20 – 100	–
Sn	Cu, Ni, Fe	1.8 – 5.5	7.5 – 35	15 – 100	–
Zn	Fe, Al	2.0 – 6.5	4.0 – 30	–	–
Lacquer	Ni, Cu, Al	11 – 40	50 – 200	80 – 800	3 – 11
Oil, grease film	Cu, Ni, Fe, Al, Mo, Ag, Au	–	–	–	1 – 11

## Phase sensitive eddy current measuring method

Standard: DIN EN ISO 21968



### Functional principle

The high-frequency magnetic field generated in the probe induces eddy currents in the copper sleeve whose magnetic field weakens the primary magnetic field. The thicker the copper sleeve, the stronger the weakening is. A specially patented probe design results in an expansion of the eddy currents that is essentially in the longitudinal axis of the copper sleeve.

### Major areas of application

- Electrical and electronics industry
- PCB manufacturing

### Suitable module types

SIGMASCOPE®/PHASCOPE® 2

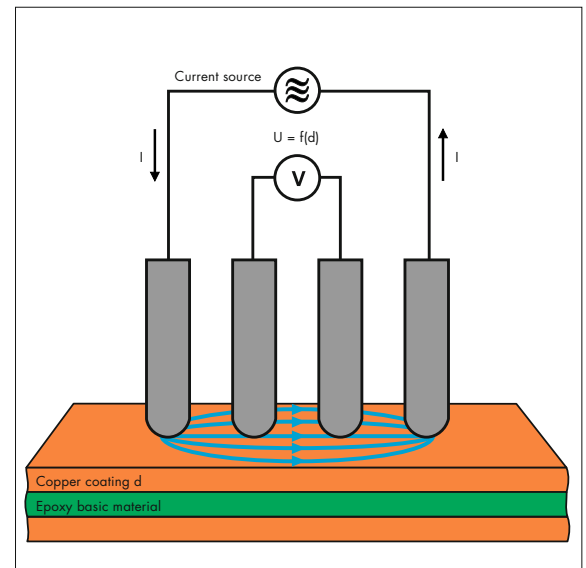
#### Note

This document does not describe all measuring methods. The brochure "Probes for Coating Thickness Measurement" contains descriptions of the following methods:

- Magnetic induction measuring method
- Eddy current measuring method
- Magnetic measuring method
- Duplex measurements

## Micro-resistance measuring method

Standard: DIN EN 14571



### Functional principle

The probe contacts the specimen surface with 4 electrodes. The two outer electrodes supply a current to the coating. The copper coating between the two inner electrodes serves as an electrical resistor at which the voltage drop is measured. This is indirectly proportional to the thickness of the copper coating. The measurement signal is converted to the coating thickness value in the measuring instrument using the probe characteristic, the functional correlation between the probe signal and the coating thickness. The electrical conductivity of the copper coating is affected by the temperature, which may make a temperature compensation necessary.

### Major areas of application

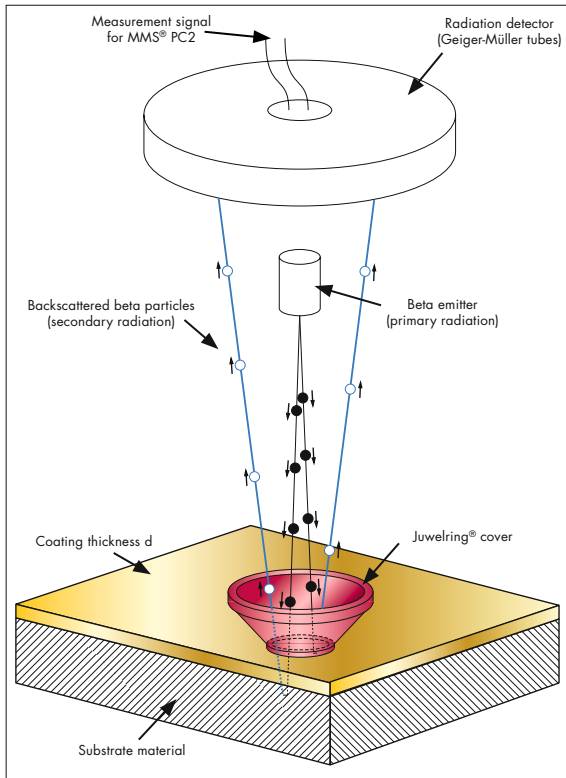
- Electrical and electronics industry
- PCB manufacturing

### Suitable module types

SR-SCOPE®

## Beta-backscatter measuring method

Standard: DIN EN ISO 3543, ASTM B567a



### Functional principle

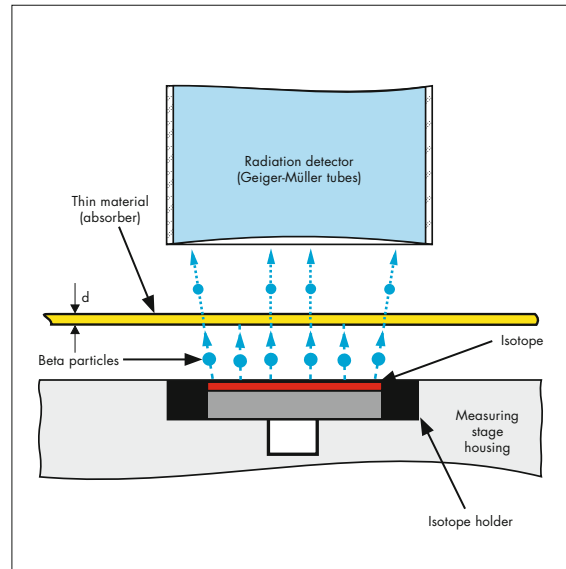
An isotope source emits beta radiation (electrons). These penetrate the surface of the coated workpiece and interact with the atoms of the coating and substrate material. The measurement effect consists of the number of backscattered electrons that are detected with a Geiger-Müller counter tube. The coating thickness can be determined with this method when the atomic numbers  $Z$  of the coating and substrate material differ by at least  $Z = 5$ .

### Major areas of application

- Printed circuit board and electronics industry
- Automobile industry
- Consumer goods industry

## Beta transmission method

Standard: DIN EN ISO 3543, ASTM B567a



### Functional principle

Analogous to the beta-backscatter method, an isotope source emits beta radiation (electrons) that are detected by the Geiger-Müller counter tube. If a thin material, e.g. a foil or a fabric, is placed in the beam path, a portion of the radiation will be absorbed by the material. The Geiger-Müller counter tube counts the number of transmitted electrons. This allows for the measurement of changes in the mass per unit area or the coating thickness in comparison to a reference part.

### Major areas of application

- Thickness inspection of foils
- Determination of the uniformity of cloths and fabrics
- Printing industry

## Accessories

### Support stand V12 BASE

Support stand with manual probe lowering. The support stand has a special lever mechanism that decelerates the lowering speed shortly before touching down, which causes the probe to touch down gently on the specimen surface.

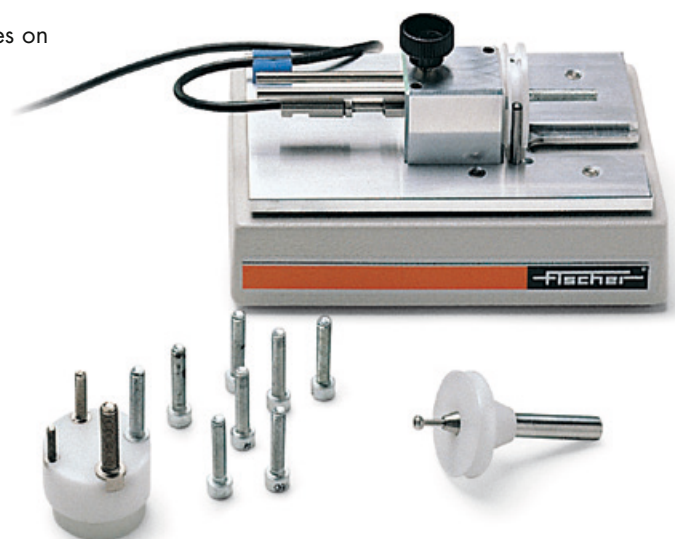
### Support stand V12 MOT

Support stand with motorised probe lowering for maximum repeatability. Control directly on the support stand or via the measuring instrument FISCHERSCOPE MMS PC2. The teach-in function guarantees a gentle touch-down of the probe on the specimen surface.



### Screw measuring device

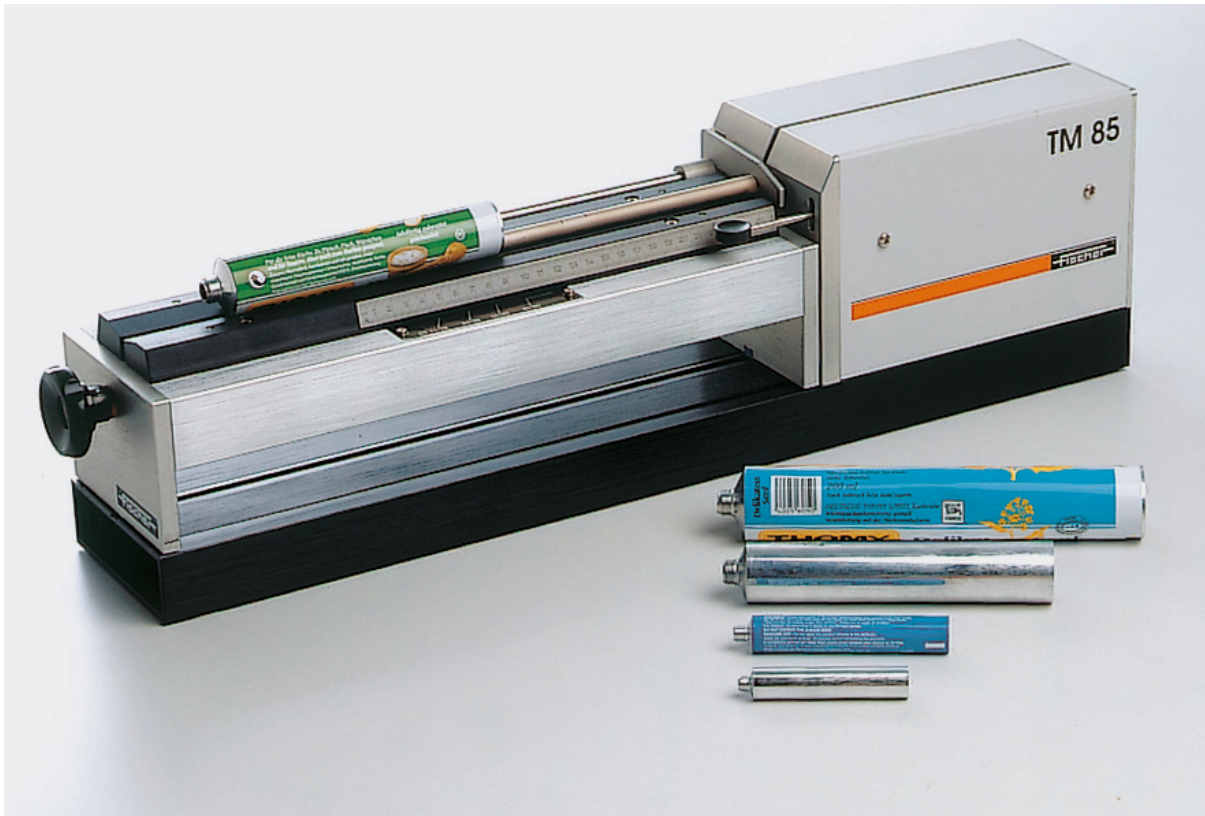
For precise measurement of coating thicknesses on metallic connection elements.





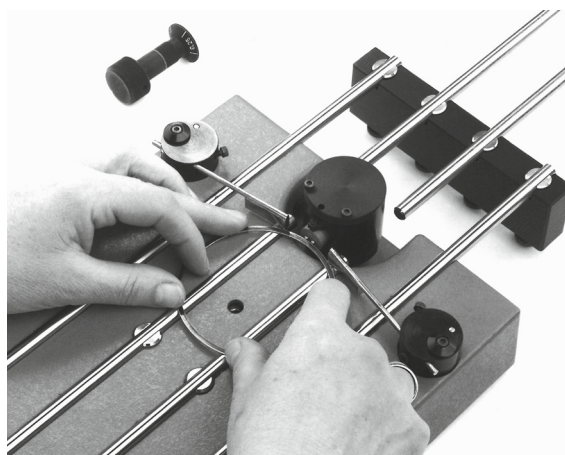
**Tube measuring station TM85**

For measuring the lacquer coating thickness on the inner or outer cladding of aluminum tubes and cans.



**Piston ring measuring stage V4EKB4**

For measuring e.g. chrome coatings on piston or oil scraper rings.



## Ordering Information

Measuring instrument FISCHERSCOPE® MMS® PC2		Slots	Order number
<b>FISCHERSCOPE® MMS® PC2 base unit</b> with LAN, USB, RS232 and multi-function connector, Windows® CE based program software, AC adapter (220 Vac/12 Vdc), software FISCHER DataCenter and PC-Datex		8 free	604-355
A description of the module boards/areas of application is found on page 8			
Module boards	Connectable probes/measuring stages	Required slots	
<b>Module board F-MODUL PERMASCOPE®</b> for upgrading a FISCHERSCOPE® MMS® PC2 base unit for coating thickness measurement according to the magnetic induction and eddy current method, incl. connection socket for measurement probes with sturdy, 10-pin connector (of type "F"). For the connection of the E-probes, order the module board PERMASCOPE® MMS® PC, order number 603-382	All magnetic induction F-probes All eddy current F-probes All dual probes (FD13H, FDX13H) All FGAB1.3*Fe probes	1	604-293
<b>Module board NICKELSCOPE®</b> for coating thickness measurement according to the magnetic test method	Probes of type EN3	1	603-383
<b>Module board SR-SCOPE®</b> for copper thickness measurement on PCB's according to the electrical micro-resistance test method	ERCU D10 ERCU N	1	603-385
<b>Module board SIGMASCOPE®/PHASCOPE® 1</b> for measurement of the coating thickness and the electrical conductivity according to the phase sensitive eddy current test method. Measuring frequencies: 60, 120, 240, 480 and 1250 kHz	ESD20Zn (Zn/Fe; Cu/Fe) ESD20Cu, ESD20Ni, ESD2.4 ES40, ES40HF ES20, ES24	2	603-592
<b>Module board SIGMASCOPE®/PHASCOPE® 2</b> for measurement of the copper thickness in PCB holes. Module board only works in connection with the module board SIGMASCOPE®/PHASCOPE® 1	ESLO80B ESLO80V	1 (3)	603-625
<b>Module board PHASCOPE® DUPLEX</b> for coating thickness measurement according the magnetic induction method, amplitude sensitive and phase sensitive eddy current test method	ESG20	1	603-730
<b>Module board TEMPERATURE</b> for temperature measurement with the temperature probe TF100A in connection with the module board SR-SCOPE® MMS® PC	Temperature probe TF100A	1	603-390
<b>DIGITALES I/O module</b> Interface module for MMS PC2, for PLC, electrically isolated, level 24 V		1	604-426



<b>General accessories</b>				Order number
Support stand V12 BASE				604-420
Support stand V12 MOT; support stand controllable from MMS® PC2 for motorised probe movement				604-374
USB connection cable for printer and support stand V12 MOT				603-398
Interface cable ActiveSync; for data exchange via the RS232 interface between MMS® PC2 and a PC				603-396
Interface cable LAN RJ45; for connecting the MMS® PC2 to a network				603-397
Interface cable LAN RJ45 twisted for connecting the MMS® PC2 to a PC with a LAN connection				603-400
Pedal for external triggering of measurement capture. Connection to the external start connection of the MMS® PC2				600-152
<b>Spare parts</b>				
Soft pencil MMS® PC2				603-857
AC adapter MMS® PC2 100 – 240 V				603-480
<b>Probes</b>				
We will be happy to help you select the right probe for your measuring application from our comprehensive range of probes				
<b>Emitter for beta probes and measuring stages</b>				
<small>All standard emitters available are listed in the following. Further aperture rings as well as special versions on request</small>				
Designation	Aperture ring opening	Energy	Half life	
PM-147	∅ 0.63 mm	0.22 MeV	2.65 years	600-488
	0.63 x 1.2 mm			600-489
TI-204	∅ 0.63 mm	0.76 MeV	3.65 years	600-490
	0.63 x 1.2 mm			600-491
SR-90	∅ 1.6 mm	2.27 MeV	28 years	600-492
C-14	∅ 20 mm	0.156 MeV	5680 years	600-493

**Helmut Fischer GmbH**  
**Institut für Elektronik und Messtechnik**  
 71069 Sindelfingen, **Germany**



**Helmut Fischer AG and**  
**Helmut Fischer Technologie AG**  
 CH-6331 Hünenberg, **Switzerland**



**IfG-Institute for Scientific Instruments GmbH**  
 12489 Berlin, **Germany**

**Fischer Instrumentation (GB) Ltd**  
 Lympington, Hampshire SO41 8JD, **England**



**Fischer Technology, Inc.**  
 Windsor, CT 06095, **USA**



**Helmut Fischer S. de R.L. de C.V.**  
 76230 Querétaro, QRO, **Mexico**

**Fischer Instrumentation Electronique**  
 78180 Montigny le Bretonneux, **France**

**Helmut Fischer S.R.L.**  
 20099 Sesto San Giovanni (Milano), **Italy**

**Fischer Instruments, S.A.**  
 08018 Barcelona, **Spain**

**Helmut Fischer Meettechniek B.V.**  
 5627 GB Eindhoven, **The Netherlands**

**Fischer do Brasil**  
 04561-001 São Paulo, **Brazil**

**Fischer Instrumentation (Taiwan) Ltd**  
 Taipei City 11493, **Taiwan**

**Fischer Instruments K.K.**  
 Saitama-ken 340-0012, **Japan**

**Nantong Fischer Instrumentation Ltd**  
 Shanghai 200333, **P.R. China**



**Fischer Instrumentation (Far East) Ltd**  
 Kwai Chung, N.T., **Hong Kong**

**Fischer Measurement Technologies (India) Pvt. Ltd**  
 Pune 411036, **India**

**Fischer Instrumentation (S) Pte Ltd**  
 Singapore 658065, **Singapore**

**Helmut Fischer Korea Co., Ltd**  
 Seoul City, **Republic of Korea**

**Fischer Technology (M) SDN Bhd**  
 47301 Petaling Jaya, **Malaysia**

**Helmut Fischer Thailand Co., Ltd**  
 Bangkok 10250, **Thailand**

**Fischer Instruments Middle East FZE**  
 P.O.Box Dubai 371 100, **United Arab Emirates**



[www.helmut-fischer.com](http://www.helmut-fischer.com)